

Notice of References Cited	Application/Control No. 10/518,246		Applicant(s)/Patent Under Reexamination SHIPTON ET AL.	
	Examiner Mark L. Berch		Art Unit 1624	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2003/0004128 A1	01-2003	Bountra et al.	514/263.23
*	B	US-2003/0004126 A1	01-2003	Bountra et al.	514/263.23
*	C	US-2003/0008842 A1	01-2003	Bountra et al.	514/263.23
*	D	US-2003/0004127 A1	01-2003	Bountra et al.	514/263.23
*	E	US-2003/0018008 A1	01-2003	Bountra et al.	514/263.23
*	F	US-2003/0004129 A1	01-2003	Bountra et al.	514/263.23
*	G	US-6,677,316 B2	01-2004	Bays et al.	514/263.23
*	H	US-2005/0176949 A1	08-2005	Berry et al.	536/027.3
*	I	US-2004/0180908 A1	09-2004	King, Paula	514/263.2
*	J	US-2002/0198170	12-2002	Bountra et al.	514/46
*	K	US-2004/0167092	08-2004	Bountra et al.	514/046
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.